

Product Change Notification / NTDO-29TVUD658

D	a	t	۵	•
u	а	L	c	

17-Nov-2021

Product Category:

Ethernet Bridges, Ethernet Controllers, USB Hubs

PCN Type:

Manufacturing Change

Notification Subject:

CCB 4623 Final Notice: Qualification of STA as an additional assembly site for LAN9220, LAN9221, LAN9500 and USB2524 SMSC device families available in 56L VQFN (8x8x0.9mm) package

Affected CPNs:

NTDO-29TVUD658_Affected_CPN_11172021.pdf NTDO-29TVUD658_Affected_CPN_11172021.csv

Notification Text:

PCN Status:Final notification

PCN Type:Manufacturing Change

Microchip Parts Affected: Please open one of the files found in the Affected CPNs section.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:Qualification of STA as an additional assembly site for LAN9220, LAN9221, LAN9500 and USB2524 SMSC device families available in 56L VQFN (8x8x0.9mm) package.

Pre and Post Change Summary:

	Pre C	hange	Post Change		
Assembly Site	ASE Inc. (ASE)		I	Inc. SE)	STATS Chippac Ltd. (STA)
Wire material	PdCu	Au	PdCu	Au	CuPdAu

Die attach material	EN-4900F	EN-4900F	8290		
Molding compound material	G631B	G631B	G700E		
Lead frame material	C194	C194	C194		
Land frame weddings	240X240 mils	240X240 mils	236X236 mils		
Lead frame paddle size	See attached pre and post change comparison				
DAP Surface Prep	Double Ring	Double Ring	Double Ring		

Impacts to Data Sheet: None

Change Impact:None

Reason for Change:To improve manufacturability by qualifying STA as an additional assembly site

Change Implementation Status:In Progress

Estimated First Ship Date:July 8, 2021 (date code: 2128)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

	May 2021				July 2021						
Workweek	1 9	2 0	2 1	2 2	2	^	2 7	2 8	2 9	3 0	3 1
Final PCN Issue Date		х									
Qual Report Availability		х									
Estimated First Ship Date								Х			

Method to Identify Change:Traceability code

Qualification Report:Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:

May 12, 2021: Issued final notification. Attached the qualification report. Provided estimated first ship date to be on July 08, 2021. **November 17, 2021:** Updated Ring Plating to Double Ring in Pre and Post Change Summary.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

PCN NTDO-29TVUD658_Pre and Post Change Comparison.pdf PCN_NTDO-29TVUD658_Qual_Report.pdf
Please contact your local Microchip sales office with questions or concerns regarding this notification.
Terms and Conditions:
If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN</u> home page select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.
If you wish to <u>change your PCN profile, including opt out,</u> please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

NTDO-29TVUD658 - CCB 4623 Final Notice: Qualification of STA as an additional assembly site for LAN9220, LAN9221, LAN9500 and USB2524 SMSC device families available in 56L VQFN (8x8x0.9mm) package

Affected Catalog Part Numbers (CPN)

LAN9220-ABZJ

LAN9221-ABZJ

LAN9221I-ABZJ

USB2524-ABZJ

LAN9500-ABZJ-A00

LAN9500I-ABZJ

LAN9500-ABZJ

LAN9500I-ABZJ-TR

Date: Tuesday, November 16, 2021

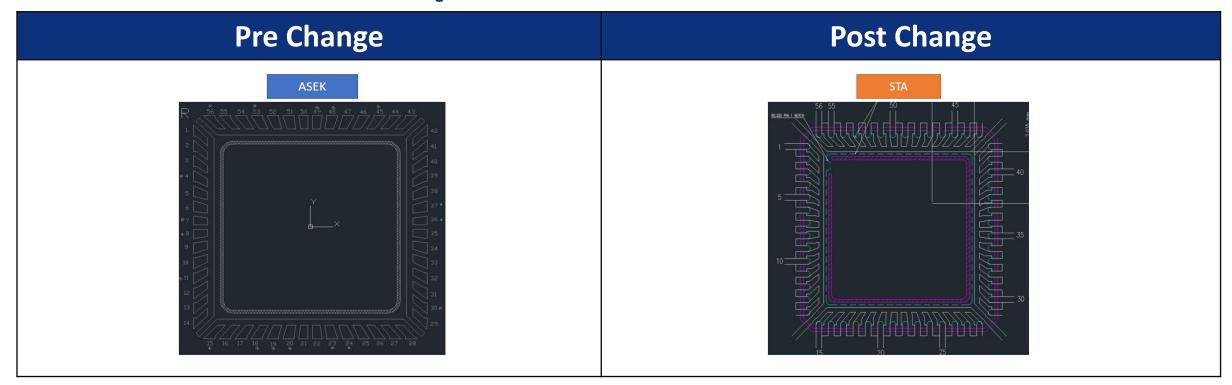
CCB 4623 Pre and Post Change Summary PCN #NTDO-29TVUD658



A Leading Provider of Smart, Connected and Secure Embedded Control Solutions



Lead frame Comparison







QUALIFICATION REPORT SUMMARY RELIABILITY LABORATORY

PCN #: NTDO-29TVUD658

Date: December 27, 2011

Qualification of STA as an additional assembly site for selected products available in 64L VQFN (9x9x0.85 mm) package. The qualification of STA as additional assembly site for selected LAN922X, LAN9500 and USB2524 devices family available in 56L VQFN (8x8x0.9mm) package will qualify by similarity (QBS).

Purpose:

Qualification of STA as an additional assembly site for selected products available in 64L VQFN (9x9x0.85 mm) package. The qualification of STA as additional assembly site for selected LAN922X, LAN9500 and USB2524 devices family available in 56L VQFN (8x8x0.9mm) package will qualify by similarity (QBS).

.1	Assembly site	STA	
Misc.	CCB No.	4623	
 	Qual ID	QAR2010-076	
11 0	Material	C194	
<u>Lead-</u> <u>Frame</u>	Lead Plating	Ag (Ring plating) / Etched	
ᆜᄔ	Leadframe Size	4.9 x 4.9 mm	
Bond Wire	Material	PdCu	
Die Att	Part Number	8290	
MC	Part Number	G700E	
(DI	PKG Type	VQFN	
PKG	Pin/Ball Count	64	
Щ	PKG width/size	9x9x0.85	

Assembly Process Data

Process	Test Item	Criteria	Sample Size	Failure/ Tested Qty.	Remarks Pass/Fail
Wafer Saw	Topside Chipping	50% max of damage	45 units/lot	0/45	Pass
	Backside Chipping	the guard ring 125µm max	45 units/lot	0/45	Pass
Die attach	Epoxy Void	10% max of die area	10 units/lot	0/10	Pass
	Bond Line	10-40µm	10 units/lot	0/10	Pass
Wirebond	Wirepull	3 gr. Min	20 wires/units 4 units	0/80	Pass
	Stitchpull	2.5 gr. Min	10 wires/units 5 units	0/50	Pass
	Ball Shear	8 gr min.	08 ball/units 5 units	0/40	Pass
	Loop Height	250 µm Max.	10 wires/units 2 units	0/20	Pass
	Cratering	0 defects	03 unit/lot All pads	0/3	Pass
	Au Intermetallic	60% min. Coverage	1 unit/lot 5 units	0/5	Pass
Mold	Wiresweep	10% max of longest wire	10 units/lot	0/10	Pass
Singulation	Package Dim	9+/-0.05mm	10 readings	0/10	Pass
		9+/-0.05mm	10 readings	0/10	Pass
Plating Thickness	Thickness	10-18μm	20 readings	0/20	Pass

SUMMARY RESULT OF RELIABILITY TEST

ITEM	CONDITION	BEFORE PRECONDITIONING O/S TEST SAT		AFT PRECOND O/S TEST	
PRECONDITIONING	30°C / 60% RH 192 HRS, Level 3 per Jedec	0/240	0/240	0/240	0/240
TEST ITEM	TEST	TE	ST	VISUAL	O/S
(With Pre-Condition)	CONDITION	INTER	RVAL	Inspection	TEST
TEMPRATURE CYCLE TEST	JEDEC 22-A104 -65'C~150'C	1000/1500 CYC		0/60	0/60
HIGH TEMPERATURE STORGE TEST	JEDEC 22-A103 150'C	1000/1500 HRS		0/60	0/60
HAST TEST (NO BIAS)	JEDEC 22-A118 130'C/85%RH 33.5PSIG	100/150 HRS		0/60	0/60
TEMPERATURE HUMIDITY TEST (NO BIAS)	JEDEC 22-A101 85'C/85%RH	1000/15	00 HRS	0/60	0/60

Test	Sample Size	Spec	Pass/Fail
Physical dimensions	15	Plastic Pkg outlines - internal specs.	15/0
Solderability	15	PI-23 Matte-Sn Plating	15/0
Marking Inspection	1	AP-51	PASS
Packing Inspection	One Inner Box	AP-71	PASS